

## POWER SCHOTTKY RECTIFIER

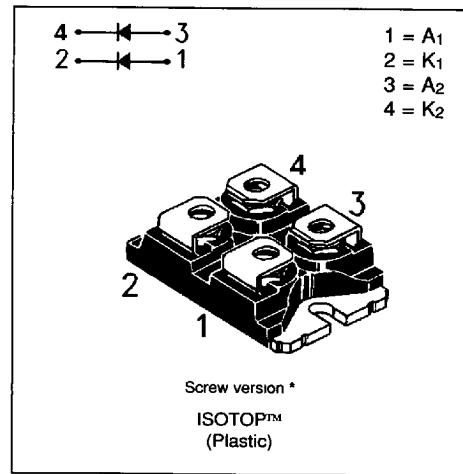
### FEATURES

- VERY SMALL CONDUCTION LOSSES
- NEGLIGIBLE SWITCHING LOSSES
- LOW FORWARD VOLTAGE DROP
- LOW THERMAL RESISTANCE
- EXTREMELY FAST SWITCHING
- INSULATED PACKAGE :  
Insulating voltage = 2500 V(RMS)

### DESCRIPTION

Dual power schottky rectifier suited for switchmode power supply and high frequency DC to DC converters.

Packaged in ISOTOP™, this device is intended for use in low voltage, high frequency inverters, free wheeling and polarity protection applications.



### ABSOLUTE RATINGS (limiting values)

Symbol	Parameter		Value	Unit
I <sub>F</sub> (RMS)	RMS forward current	Per diode	125	A
I <sub>F</sub> (AV)	Average forward current	T <sub>c</sub> =85°C $\delta = 0.5$	Per diode	80
			Per device	160
I <sub>FSM</sub>	Surge non repetitive forward current	tp=10ms sinusoidal	900	A
I <sub>RRM</sub>	Peak repetitive reverse current	tp=2μs F=1kHz	2	A
T <sub>stg</sub> T <sub>J</sub>	Storage and junction temperature range		- 65 to + 150 - 65 to + 150	°C °C
dV/dt	Critical rate of rise of reverse voltage		1000	V/μs

Symbol	Parameter	STPS		Unit
		16035TV	16045TV	
V <sub>RRM</sub>	Repetitive peak reverse voltage	35	45	V

\* : Tin plated Fast-on version is also available (without V suffix)

TM : ISOTOP is a trademark of SGS-THOMSON Microelectronics

**THERMAL RESISTANCES**

Symbol	Parameter	Value	Unit
R <sub>th</sub> (j-c)	Junction to case	0.9	°C/W
		0.5	
R <sub>th</sub> (c)	Coupling	0.1	°C/W

When the diodes 1 and 2 are used simultaneously :

$$\Delta T_j(\text{diode } 1) = P(\text{diode}) \times R_{th}(\text{Per diode}) + P(\text{diode } 2) \times R_{th}(c)$$

**ELECTRICAL CHARACTERISTICS (Per diode)**

**STATIC CHARACTERISTICS**

Symbol	Test Conditions		Min.	Typ.	Max.	Unit
I <sub>R</sub> *	T <sub>j</sub> = 25°C	V <sub>R</sub> = V <sub>RRM</sub>			1	mA
	T <sub>j</sub> = 125°C				150	mA
V <sub>F</sub> **	T <sub>j</sub> = 125°C	I <sub>F</sub> = 160 A			0.90	V
	T <sub>j</sub> = 125°C	I <sub>F</sub> = 80 A			0.69	
	T <sub>j</sub> = 25°C	I <sub>F</sub> = 160 A			0.95	

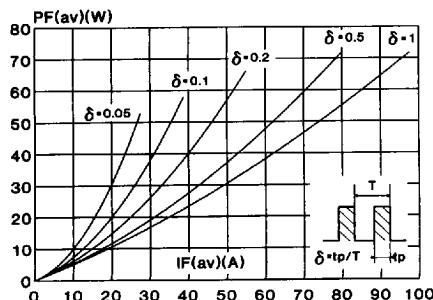
Pulse test : \* t<sub>p</sub> = 5 ms, duty cycle < 2 %

\*\* t<sub>p</sub> = 360 μs, duty cycle < 2 %

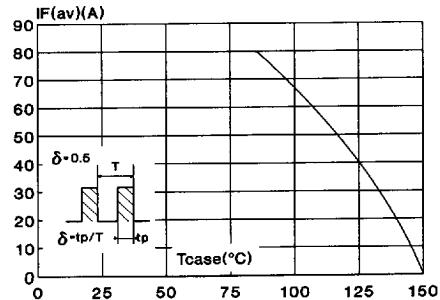
To evaluate the conduction losses use the following equation :

$$P = 0.48 \times I_F(AV) + 0.00262 \times I_F^2(\text{RMS})$$

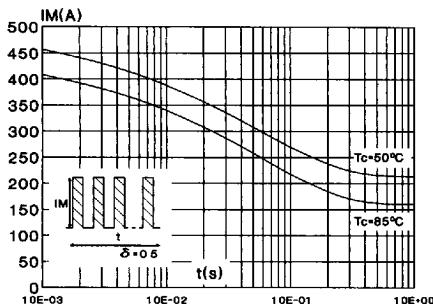
**Fig.1 : Average forward power dissipation versus average forward current. (Per diode)**



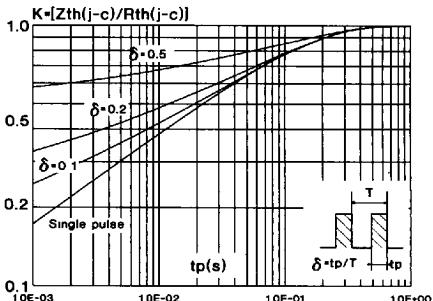
**Fig.2 : Average current versus case temperature. (duty cycle : 0.5) (Per diode)**



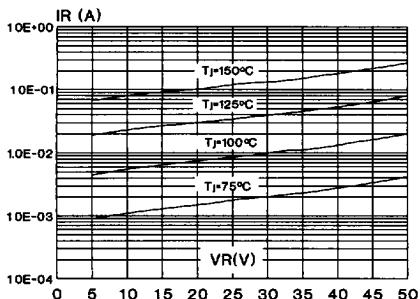
**Fig.3** : Non repetitive surge peak forward current versus overload duration. (Maximum values) (Per diode)



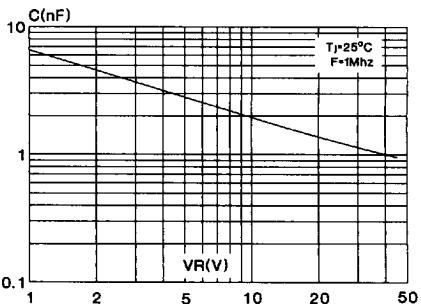
**Fig.4** : Relative variation of thermal transient impedance junction to case versus pulse duration.



**Fig.5** : Reverse leakage current versus reverse voltage applied. (Typical values) (Per diode)



**Fig.6** : Junction capacitance versus reverse voltage applied. (Typical values) (Per diode)



**Fig.7** : Forward voltage drop versus forward current. (Maximum values) (Per diode)

